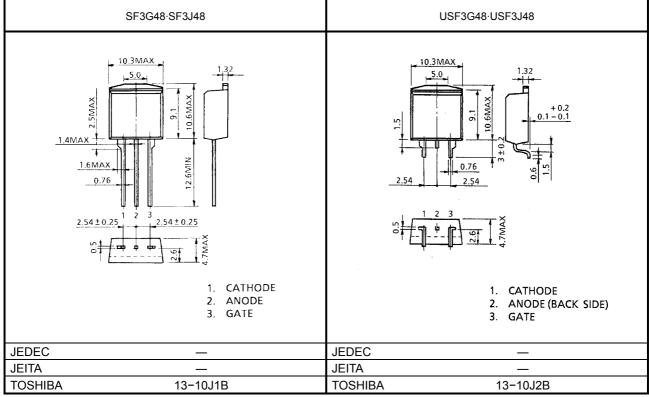
## TOSHIBA THYRISTOR SILICON PLANAR TYPE

# SF3G48,SF3J48,USF3G48,USF3J48

## MEDIUM POWER CONTROL APPLICATIONS

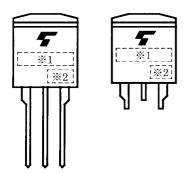
 Repetitive Peak Off-State Voltage : VDRM = 400,600V Repetitive Peak Reverse Voltage : VRRM = 400,600V
 Average On-State Current : IT (AV) = 3A
 Gate Trigger Current : IGT = 10mA MAX.

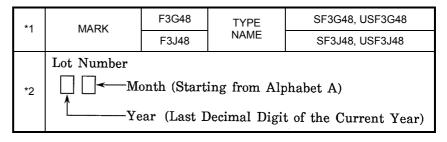
Unit: mm



Weight: 1.7g

#### **MARKING**







# **MAXIMUM RATINGS**

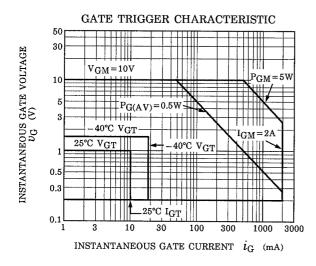
CHARACTERISTIC		SYMBOL	RATING	UNIT	
Repetitive Peak Off-State Voltage and	SF3G48 USF3G48	$V_{DRM}$	400	٧	
Repetitive Peak Reverse Voltage	SF3J48 USF3J48	$V_{RRM}$	600		
Non-Repetitive Peak Reverse Voltage (Non-Repetitive <5ms, T <sub>j</sub> = 0~125°C)	SF3G48 USF3G48	V <sub>RSM</sub>	500	V	
	SF3J48 USF3J48	VRSM	720		
Average On-State Current		I <sub>T (AV)</sub>	3	Α	
R.M.S On-State Current		I <sub>T (RMS)</sub>	4.7	Α	
Peak One Cycle Surge On-State Current (Non-Repetitive)		I <sub>TSM</sub>	50 (50Hz)	Α	
			55 (60Hz)		
I <sup>2</sup> t Limit Value		I <sup>2</sup> t	12.5	A <sup>2</sup> s	
Critical Rate of Rise of On-State Current (Note 1)		di / dt	100	A / µs	
Peak Gate Power Dissipation		P <sub>GM</sub>	5	W	
Average Gate Power Dissipation		P <sub>G (AV)</sub>	0.5	W	
Peak Forward Gate Voltage		$V_{FGM}$	10	V	
Peak Reverse Gate Voltage		$V_{RGM}$	-5	V	
Peak Forward Gate Current		I <sub>GM</sub>	2	Α	
Junction Temperature		Tj	-40~125	°C	
Storage Temperature Range		T <sub>stg</sub>	-40~125	°C	

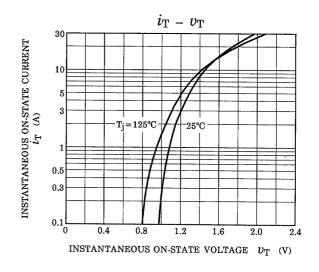
Note 1: V<sub>DRM</sub> = 0.5 × Rated

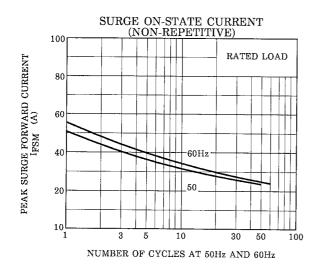
 $I_{TM} \le 12A$   $t_{gW} \ge 10\mu s$   $t_{gr} \le 250ns$  $i_{gp} = I_{GT} \times 2.0$ 

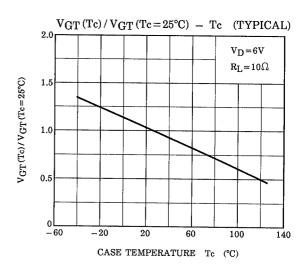
# **ELECTRICAL CHARACTERISTICS (Ta = 25°C)**

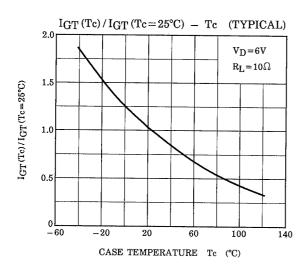
CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN	TYP.	MAX	UNIT
Repetitive Peak Off-State Current and Repetitive Peak Reverse Current	I <sub>DRM</sub> I <sub>RRM</sub>	V <sub>DRM</sub> = V <sub>RRM</sub> = Rated	_	_	10	μΑ
Peak On-State Voltage	$V_{TM}$	I <sub>TM</sub> = 12A	_	_	1.5	V
Gate Trigger Voltage	V <sub>GT</sub>	$V_D = 6V, R_1 = 10\Omega$	-	_	1.0	V
Gate Trigger Current	I <sub>GT</sub>	VD - 0V, NL - 1012	_	_	10	mA
Gate Non-Trigger Voltage	$V_{GD}$	V <sub>D</sub> = Rated × 2 / 3, Tc = 125°C	0.2	_	_	V
Critical Rate of Rise of Off-State Voltage	dv / dt	V <sub>DRM</sub> = Rated, Tc = 125°C Exponential Rise	_	50	-	V / µs
Holding Current	lΗ	V <sub>D</sub> = 6V, I <sub>TM</sub> = 1A	-	_	40	mA
Latching Current	ΙL	$V_D = 6V, f = 50Hz$ $t_{gw} = 50\mu s, i_G = 30mA$		_	50	mA
Thermal Resistance	R <sub>th (j−c)</sub>	Junction to Case, DC	_	_	3.6	°C/W

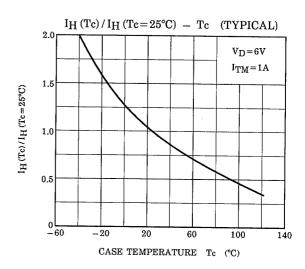


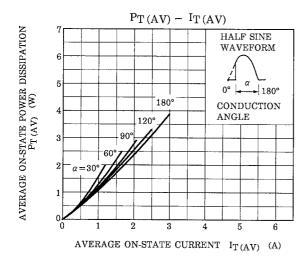


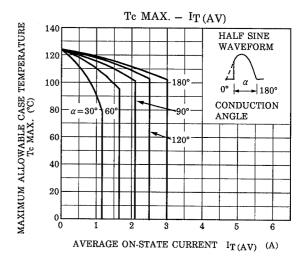


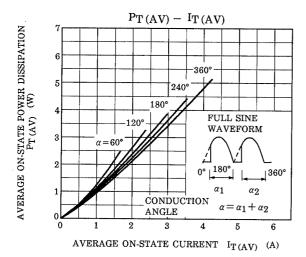


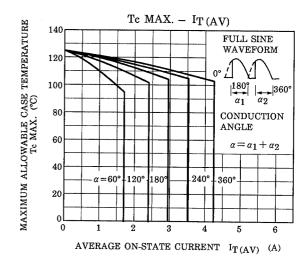


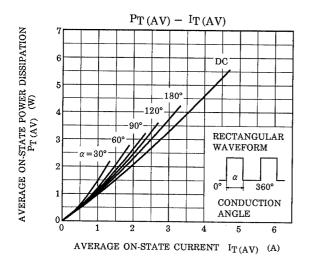


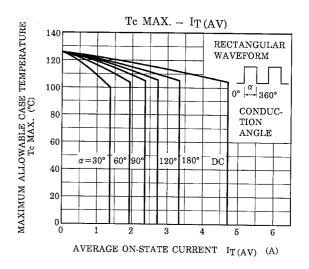




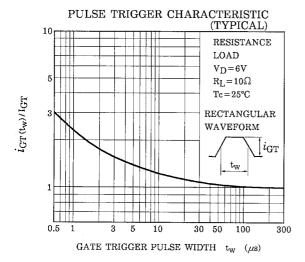


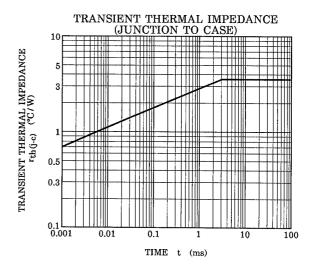






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## **RESTRICTIONS ON PRODUCT USE**

Handbook" etc..

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